 ch No	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/714,780	WONG ET AL.	
Examiner	Art Unit	
Horace L. Flournoy	2189	

	SEARCHED		
Class	Subclass	Date	Examiner
		-	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
-			

SEARCH N (INCLUDING SEAR)		)
	DATE	EXMR
Inventor Search (PALM)	1/19/2006	HF
Fast & Focused EIC search	1/18/2006	HF
711/167 with Key Word Search	1/18/2006	HF